

UNISONIC TECHNOLOGIES CO., LTD

8N50 **Power MOSFET**

8A, 500V **N-CHANNEL POWER MOSFET**

DESCRIPTION

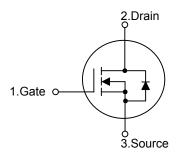
The UTC 8N50 is an N-channel mode power MOSFET using UTC's advanced technology to provide customers with planar stripe and DMOS technology. This technology allows a minimum on-state resistance and superior switching performance. It also can withstand high energy pulse in the avalanche and commutation mode.

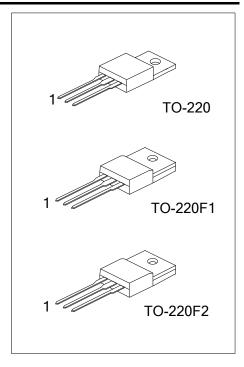
The UTC 8N50 is generally applied in high efficiency switch mode power supplies, active power factor correction and electronic lamp ballasts based on half bridge topology.

FEATURES

- * $R_{DS(ON)}$ < 0.85 Ω @ V_{GS} =10V, I_{D} =4.5A
- * High Switching Speed
- * 100% Avalanche Tested

SYMBOL

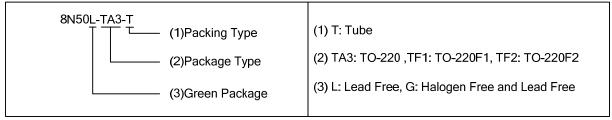




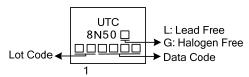
ORDERING INFORMATION

Ordering Number		Doolsons	Pin Assignment			Doolsing	
Lead Free	Halogen Free	Package	1	2	3	Packing	
8N50L-TA3-T	8N50G-TA3-T	TO-220	G	D	S	Tube	
8N50L-TF1-T	8N50G-TF1-T	TO-220F1	G	D	S	Tube	
8N50L-TF2-T	8N50G-TF2-T	TO-220F2	G	D	S	Tube	

Note: Pin Assignment: G: Gate D: Drain S: Source



MARKING



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■ ABSOLUTE MAXIMUM RATINGS (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V _{DSS}	V _{DSS} 500		
Gate-Source Voltage		V _{GSS}	±30	V	
Drain Current	Continuous (T _C =25°C)	I _D	8(Note 2)	А	
	Pulsed (Note 3)	I _{DM}	32(Note 2)	А	
Avalanche Current (Note 3)		I _{AR}	8	А	
Avalanche Energy	Single Pulsed (Note 4)	E _{AS}	320	mJ	
	Repetitive (Note 5)	E _{AR}	12.5	mJ	
Power Dissipation	TO-220		125		
	TO-220F1		42	W	
	TO-220F2		62.5		
Derate above 25°C	TO-220	P _D	1		
	TO-220F1		0.33	W/°C	
	TO-220F2		0.5		
Junction Temperature		TJ	+150	°C	
Storage Temperature		T _{STG}	-55~+150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Drain current limited by maximum junction temperature
- 3. Repetitive Rating: Pulse width limited by maximum junction temperature
- 4. L = 10mH, I_{AS} = 8A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25 $^{\circ}$ C
- 5. $I_{SD} \le 8A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT	
Junction to Ambient		θ_{JA}	62.5	°C/W	
Junction to Case	TO-220		1	°C/W	
	TO-220F1	$\theta_{ m JC}$	3		
	TO-220F2		2		

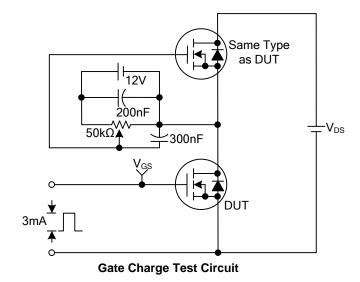
■ ELECTRICAL CHARACTERISTICS (T_C=25°C, unless otherwise specified)

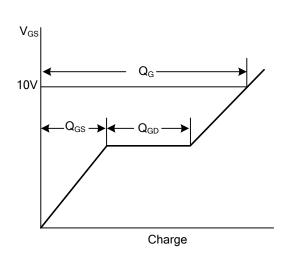
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV _{DSS}	I _D =250μA, V _{GS} =0V	500			V
Drain-Source Leakage Current		I_{DSS}	V _{DS} =500V, V _{GS} =0V			25	μΑ
Gate- Source Leakage Current	Forward	I _{GSS}	V _{GS} =+30V, V _{DS} =0V			+100	nA
	Reverse		V _{GS} =-30V, V _{DS} =0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_D=250\mu A$	2.0		4.0	V
Static Drain-Source On-State Resistance		R _{DS(ON)}	V_{GS} =10V, I_D =4.5A		0.62	0.85	Ω
DYNAMIC PARAMETERS							
Input Capacitance		C_{ISS}			650		pF
Output Capacitance		Coss	V _{GS} =0V, V _{DS} =25V, f=1.0MHz		112		pF
Reverse Transfer Capacitance		C_{RSS}			21		pF
SWITCHING PARAMETERS							
Total Gate Charge		Q_G	-\/ -10\/ \/ -400\/ -94		35		nC
Gate to Source Charge		Q_GS	V _{GS} =10V, V _{DS} =400V, I _D =8A (Note 1, 2)		7		nC
Gate to Drain Charge		Q_GD	(Note 1, 2)		11		nC
Turn-ON Delay Time		$t_{D(ON)}$			50		ns
Rise Time		t_R	V _{DD} =250V, I _D =8A, R _G =25Ω (Note 1, 2)		80		ns
Turn-OFF Delay Time		$t_{D(OFF)}$			260		ns
Fall-Time		t_{F}			35		ns
SOURCE- DRAIN DIODE RATII	NGS AND (CHARACTERI	STICS				
Maximum Body-Diode Continuous Current		I _S				8	Α
Maximum Body-Diode Pulsed Current		I _{SM}				32	Α
Drain-Source Diode Forward Voltage		V_{SD}	I _S =8A, V _{GS} =0V			1.4	V
Body Diode Reverse Recovery Time		t _{rr}	I_S =8A, V_{GS} =0V, dI_F/dt =50A/ μ s (Note 1)		800		ns

Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%

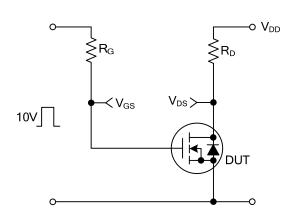
^{2.} Essentially independent of operating temperature

■ TEST CIRCUITS AND WAVEFORMS

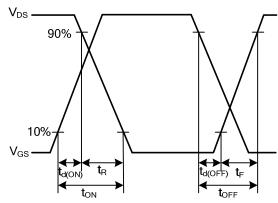




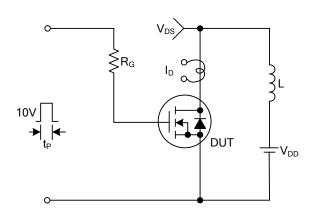
Gate Charge Waveforms



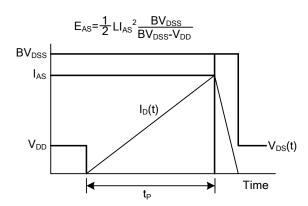
Resistive Switching Test Circuit



Resistive Switching Waveforms

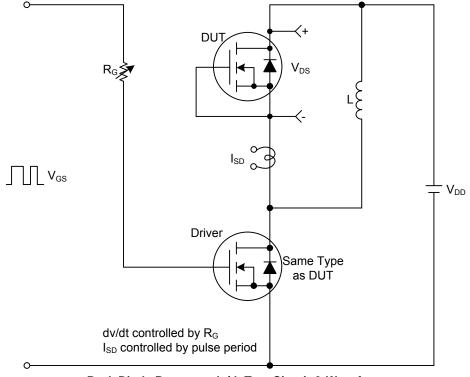


Unclamped Inductive Switching Test Circuit

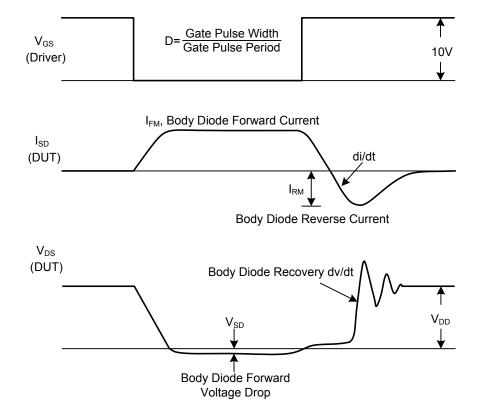


Unclamped Inductive Switching Waveforms

■ TEST CIRCUITS AND WAVEFORMS(Cont.)



Peak Diode Recovery dv/dt Test Circuit & Waveforms



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